## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10555664	ASSAF ET AL.
Examiner	Art Unit
Loewe, Sun Jae Y	1626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES			
Search Notes	Date	Examiner	
restriction requirement	10/1/2007	sl	
stn structure: registry & caplus	12-28-2007	sl	
palm all inventors	12-28-2007	sl	
STN: registry & caplus updated	9-29-2008	sl	
PALM all inventor updated	9-29-08	sl	
STN registry & caplus updated	5-5-2009	sl	
PALM all inventors updated	5-5-2009	sl	
STN registry & caplus updated	12-4-2009	sl	
PALM all inventors updated	12-4-2009	sl	
STN registry&caplus updated	8-5-2010	sl	
PALM all inventors updated	8-5-2010	sl	
STN registry&caplus updated	12-27-2010	sl	
PALM all inventors updated	12-27-2010	sl	
patentability conference: R. Havlin, J. McKane	2-10-2011	sl	

INTERFERENCE SEARCH				
Class		Subclass	Date	Examiner
514	365		2-10-2011	sl
548	202		2-10-2011	sl

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